

N-Channel 650V (D-S) Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	650)		
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V	1.1		
Q _g max. (nC)	25			
Q _{gs} (nC)	2.0)		
Q _{gd} (nC)	2.7	7		
Configuration	Single			

FEATURES

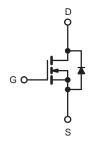
- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	less otherwis	se noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 30	7 v
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I _D -	7.0	
Continuous Drain Current (1) = 130 C)	VGS at 10 V	T _C = 100 °C		5.6	Α
Pulsed Drain Current ^a		I _{DM}	28		
Linear Derating Factor			1.67/1.5/0.3	W/°C	
Single Pulse Avalanche Energy b		E _{AS}	86	mJ	
Maximum Power Dissipation			P _D	83/83/31	W
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope T _J = 125 °C		al\	50	1//22	
Reverse Diode dV/dt ^d		dV/dt	4.5	- V/ns	
Soldering Recommendations (Peak Temperature) c for 10 s		10 s		300	°C

- a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD}=50$ V, starting $T_J=25$ °C, L=28.2 mH, $R_g=25$ Ω , $I_{AS}=3.5$ A.

- c. 1.6 mm from case. d. $I_{SD} \le I_D$, dl/dt = 100 A/ μ s, starting $T_J = 25$ °C.



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	63	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.6	G/ VV

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					l		•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	650	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.65	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.5	-	5	V	
			V _{GS} = ± 20 V	-	-	± 100	nA	
Gate-Source Leakage	I_{GSS}		V _{GS} = ± 30 V	-	-	± 1	μA	
	_	V _{DS} =	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	V V/°C V nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 520 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4 A	-	1.1	-	Ω	
Forward Transconductance	9fs	V _{DS}	s = 30 V, I _D = 4 A	-	16	-	S	
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V$	-	860	-		
Output Capacitance	C _{oss}	1	$V_{DS} = 100 \text{ V},$	-	120	-		
Reverse Transfer Capacitance	C _{rss}	1	f = 1 MHz		15	-	1	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}		/+- 500 V V 0 V	-	45	-	pF	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	V _{DS} = 0 \	/ to 520 V, V _{GS} = 0 V	-	62	-		
Total Gate Charge	Qg			-	25			
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 4 A, V_{DS} = 520 V$	-	2.0	-	nC	
Gate-Drain Charge	Q_{gd}			-	2.7	-		
Turn-On Delay Time	t _{d(on)}			-	25	-		
Rise Time	t _r	V_{DD} = 520 V, I_{D} = 4 A, V_{GS} = 10 V, R_{g} = 9.1 Ω		-	55	-	ne	
Turn-Off Delay Time	$t_{d(off)}$			-	70	-	113	
Fall Time	t _f			-	40	-		
Gate Input Resistance	R_g	f = 1	MHz, open drain	-	3.5	-	Ω	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	7		
Pulsed Diode Forward Current	I _{SM}	integral revers p - n junction	7 	-	-	18		
Diode Forward Voltage	V _{SD}	T _J = 25 °	C, I _S = 4 A, V _{GS} = 0 V	-	-	1.5	V	
Reverse Recovery Time	t _{rr}			-	190	-	ns	
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 4 \text{ A},$ $dI/dt = 100 \text{ A/}\mu\text{s}, V_R = 400 \text{ V}$		-	2.3	-	μC	
Reverse Recovery Current	I _{RRM}			<u> </u>	10	 	A	

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

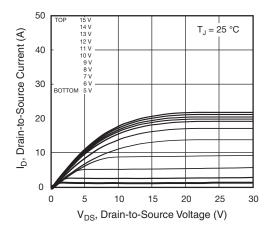


Fig. 1 - Typical Output Characteristics

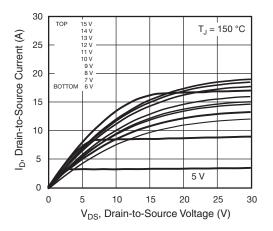


Fig. 2 - Typical Output Characteristics

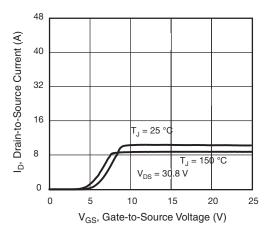


Fig. 3 - Typical Transfer Characteristics

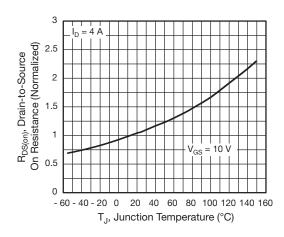


Fig. 4 - Normalized On-Resistance vs. Temperature

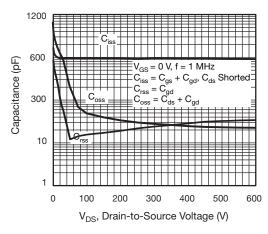


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

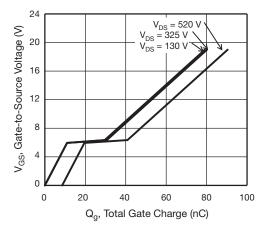


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



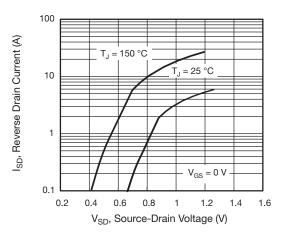


Fig. 7 - Typical Source-Drain Diode Forward Voltage

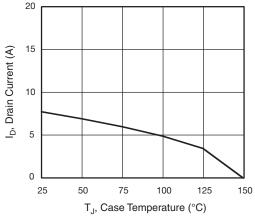


Fig. 9 - Maximum Drain Current vs. Case Temperature

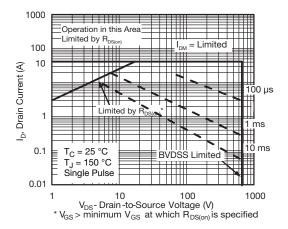


Fig. 8 - Maximum Safe Operating Area

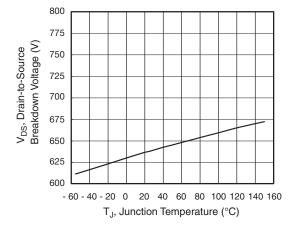


Fig. 10 - Temperature vs. Drain-to-Source Voltage

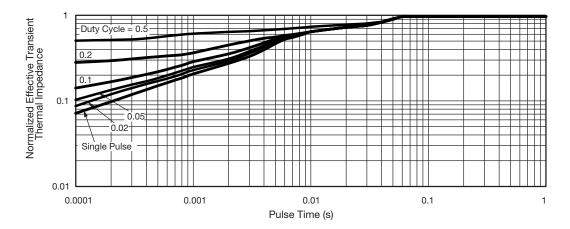


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



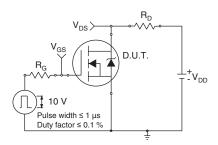


Fig. 12 - Switching Time Test Circuit

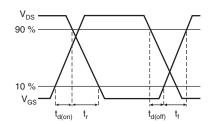


Fig. 13 - Switching Time Waveforms

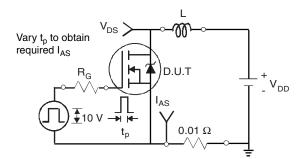


Fig. 14 - Unclamped Inductive Test Circuit

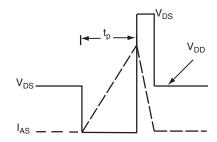


Fig. 15 - Unclamped Inductive Waveforms

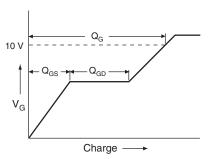


Fig. 16 - Basic Gate Charge Waveform

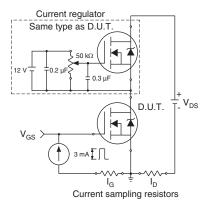
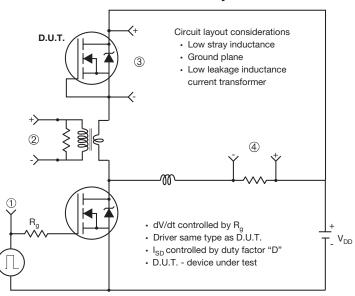


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



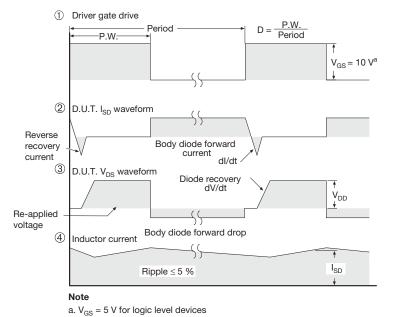
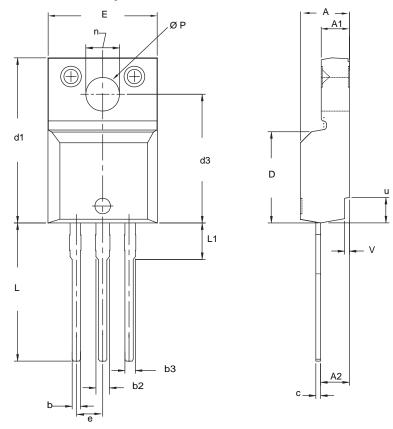


Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



		METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100	BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

Notes

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
 All dimensions include burrs and plating thickness.

- 5. No chipping or package damage.



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